IAP15 Rec d PCT/PTO 11 APR 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Junichi TANAKA et al.

Application No.: New U.S. National Stage of

PCT/JP2004/017078

Filed: April 11, 2006 Docket No.: 127648

For: METHOD AND DEVICE FOR EXAMINATION OF NONUNIFORMITY DEFECTS OF

PATTERNS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of one or more non-English language reference is discussed in the present specification. See Reference 2.
- 3. One or more reference cited herein was cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information. See Reference 1.
- 4. An English language Abstract of one or more non-English language reference is attached hereto. See References 1-2.
- 5. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See References 1-2.

Respectfully submitted

Registration No. 27,075

William P. Berridge (Registration No. 30,024

JAO:WPB/jrb

Date: April 11, 2006

OLIFF & BERRIDGE, PLC P.O. Box 19928 Alexandria, Virginia 22320 Telephone: (703) 836-6400 DEPOSIT ACCOUNT USE
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Form PTO-1449 (REV. 1/06) INFORMA		US Dept. of Commerce PATENT & TRADEMARK OFFICE ATION DISCLOSURE STATEMENT		ATTY DOCKET NO. 127648			APPLICATION NO. New U.S. National Stage of PCT/JP2004/017078		
(Use several sheets if necessary)				APPLICANTS Junichi TANAKA et al.		000000000000000000000000000000000000000	Art Unit 2877		
				FILING DATE April 11, 2006			Examiner Iyabo Alli		
U.S. PATENT DOCUMENTS									
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FOREIGN PATENT DOCUMENTS									
Examiner Initials	Cite No.	Document Number	Da	te	Country		With English Abstract	With English Translation	
/IA/	1	JP A 2003-297888 10	10/17/2003		Japan		x	х	
/IA/	2	JP A 10-300447	1/13/19	98	Japan		х	х	

OTHER DOCUMENTS									
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EXAMINER /lyabo Alli/ (02/11/2008)					DATE CONSIDERED 02/11/2008)	
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									

Date: April 11, 2006